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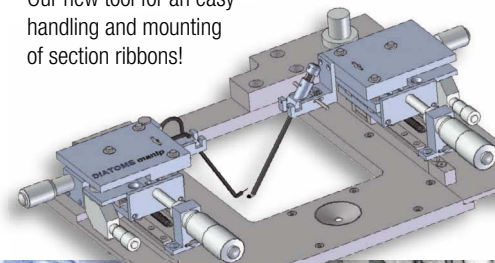
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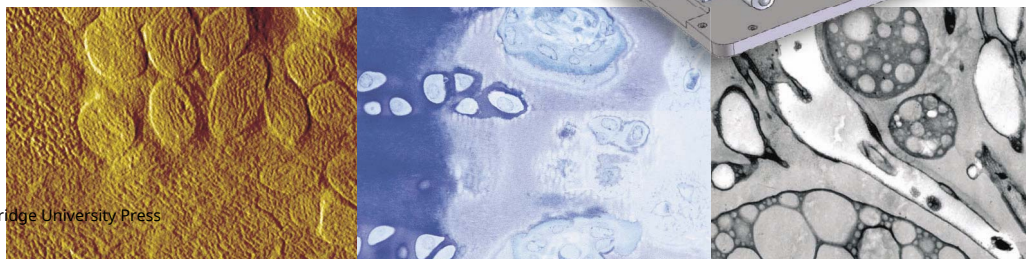
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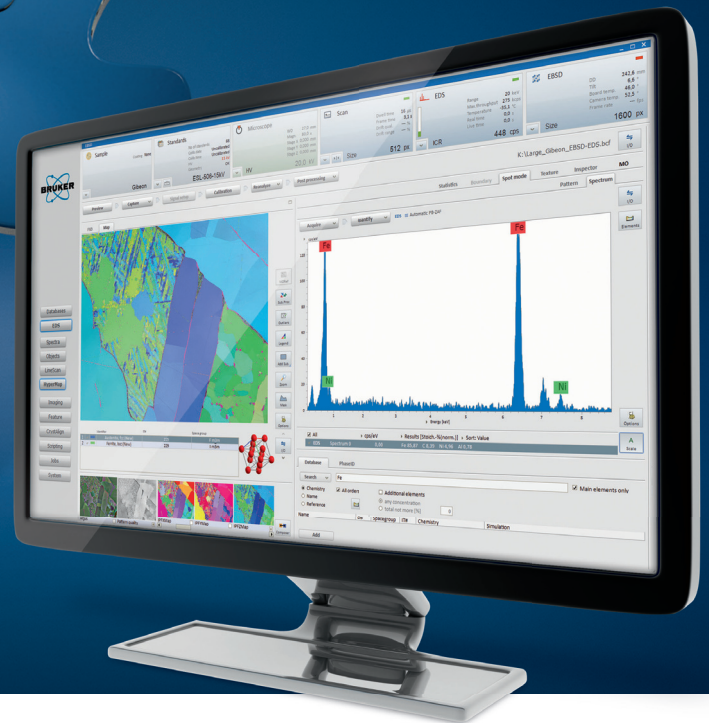
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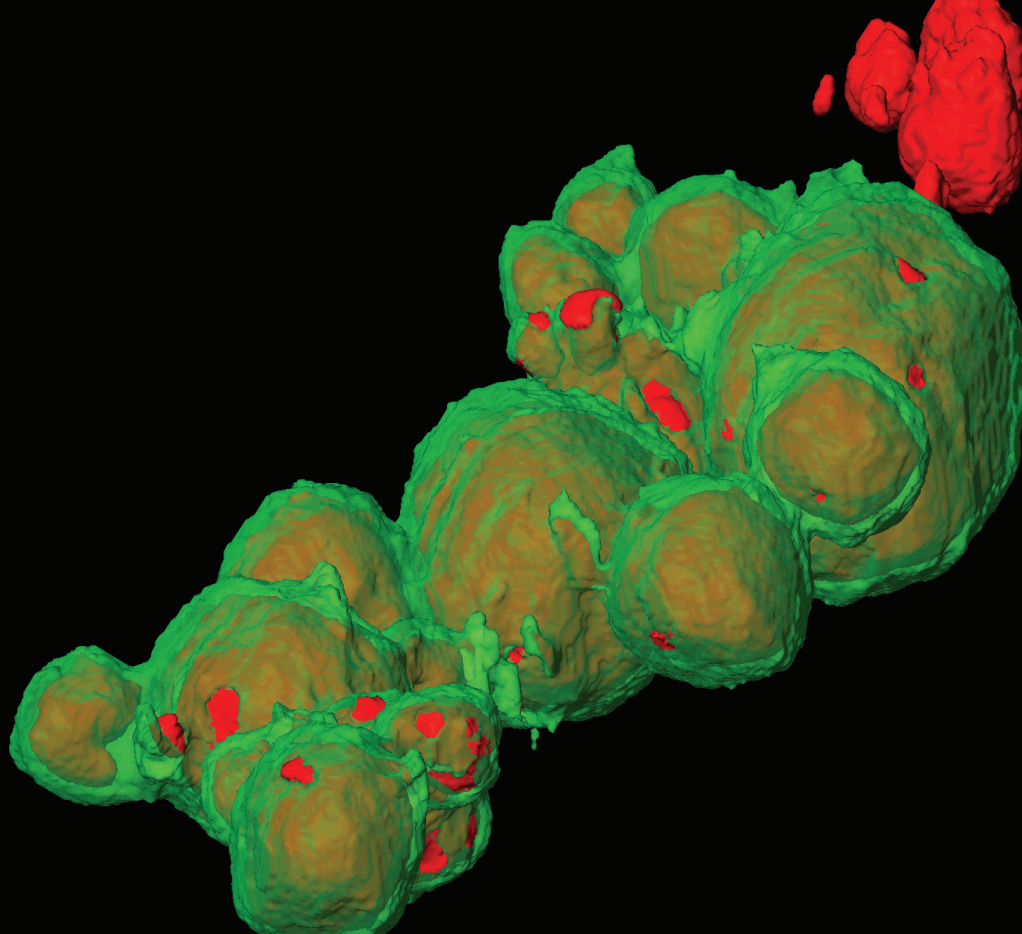


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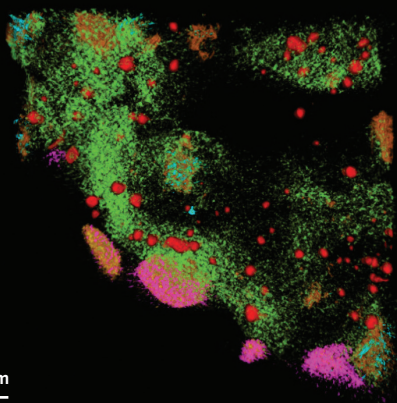
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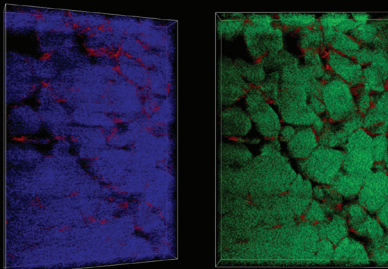
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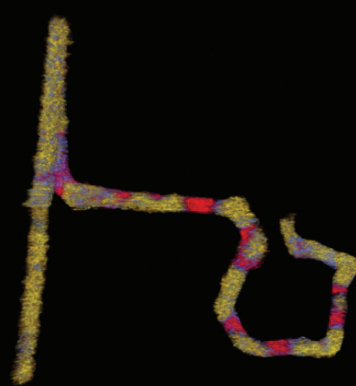
C

C
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D

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In



A: EDS tomogram of Ag-Pt core-shell nanoparticles. Ag cores are shown in the false color of red, covered by green-colored Pt shells, only a few nanometers in thickness. Sample courtesy Prof. Yi Ding and Prof. Jun Luo, Center for Electron Microscopy, Tianjin University of Technology. **B: Vehicle-aged automotive catalyst.** EDS tomogram showing the distribution of Palladium particles (red) relative to other elements. **C: Battery anode material.** EDS tomograms of Carbon-Cobalt and Carbon-Aluminum. **D: EDS tomogram of P-Zn-In nanotubes.** Sample Courtesy of Dr. Reza Shahbazian Yassar, Michigan Tech University.

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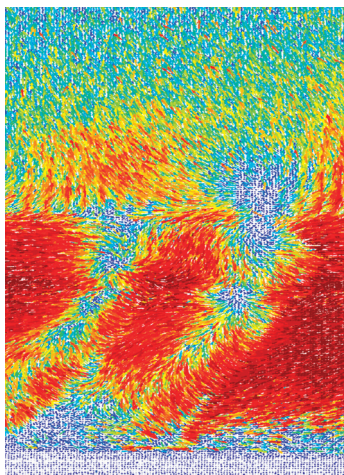
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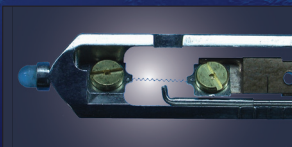
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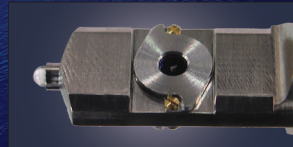
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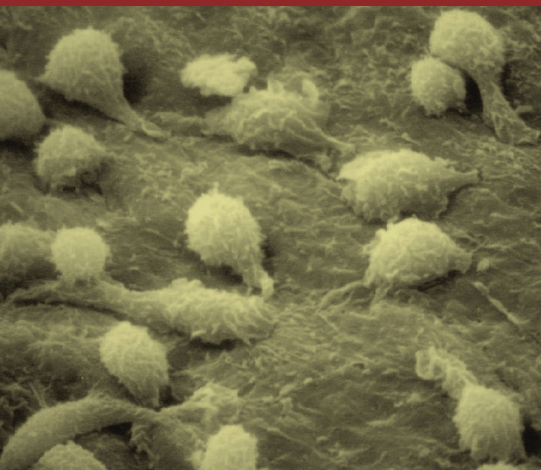
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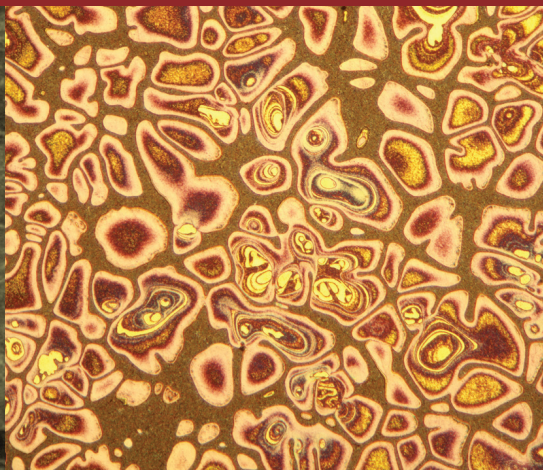
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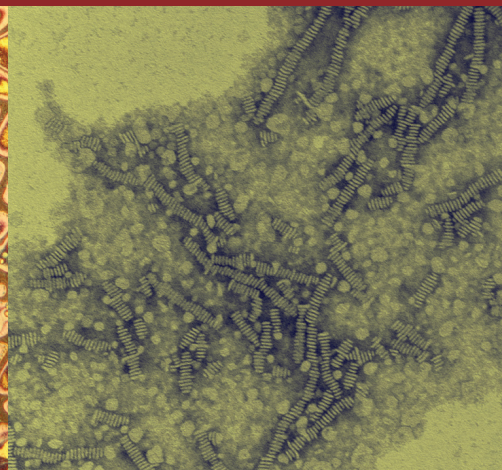
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Program Information | Information for Students | Meeting Awards | Exhibitor List & Floor Plan
Registration (*Opens March 2016*) | Columbus Hotel Information (*Hotel Reservations Now Open*)

